

SUBSTITUTE FORM PTO-1449
(MODIFIED)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET #
07977/124001

Sheet 1

SERIAL NO.
08/802,276

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(Use several sheets if necessary)

APPLICANT:
Yamazaki, et al.

FILING DATE
February 19, 1997

GROUP ART UNIT
2813

(37 CFR 1.98(b))

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER							ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5	4	0	3	7	7	2	4/4/95	Zhang et al.	437	101	
	AB	5	4	2	6	0	6	4	6/20/95	Zhang et al.	437	40	
	AC	5	4	8	1	1	2	1	1/2/96	Zhang et al.	257	64	
	AD	5	4	8	8	0	0	0	1/30/96	Zhang et al.	437	21	
	AE	5	4	9	2	8	4	3	2/20/96	Adachi et al.	437	21	
	AF	5	5	0	1	9	8	9	3/26/96	Takayama et al.	437	21	
	AG	5	5	0	6	5	3	3	4/16/96	Takemura	257	66	
	AX	5	5	7	6	6	3	7	6/25/96	Zhang et al.	437	10	
	AF	5	5	3	4	7	1	6	7/9/96	Takemura	257	72	
	AV	5	5	4	3	3	5	7	8/6/96	Ohtani et al.	437	101	
	AK	5	5	6	3	4	2	6	10/8/96	Zhang et al.	257	66	
	AL	5	5	6	9	6	1	0	10/29/96	Zhang et al.	437	21	
	AM	5	5	6	9	9	3	6	10/29/96	Zhang et al.	257	66	
	AN	5	5	8	0	7	9	2	12/3/96	Zhang et al.	437	10	
	AO	5	5	8	5	2	9	1	12/17/96	Ohtani et al.	437	40	
	AP	5	5	8	9	6	9	4	12/31/96	Takayama et al.	257	67	
	AQ	5	5	9	5	9	2	3	1/21/97	Zhang et al.	437	41	
	AR	5	5	9	5	9	4	4	1/21/97	Zhang et al.	437	41	
	AS	5	6	0	4	3	6	0	2/18/97	Zhang et al.	257	72	
	AT	5	6	0	5	8	4	6	2/25/97	Ohtani et al.	437	21	
	AU	5	6	0	6	1	7	9	2/25/97	Yamazaki et al.	257	59	
	AV	5	6	0	6	2	3	2	3/4/97	Yamazaki et al.	257	66	
	AV	5	6	1	2	2	5	9	3/18/97	Ohtani et al.	437	101	
	AX	5	6	1	6	6	7	6	3/25/97	Funada et al.	437	66	
	AX	5	6	1	6	7	3	3	3/18/97	Zhang et al.	257	66	
	AZ	5	6	1	6	5	0	6	4/1/97	Takemura	438	150	
		5	6	2	0	9	1	0	4/15/97	Teramoto	438	151	
	BA	5	6	2	1	2	2	4	4/15/97	Yamazaki et al.	257	66	
	BB	5	6	2	4	8	5	1	4/29/97	Takayama et al.	438	166	
	BC	5	6	3	7	5	1	5	6/10/97	Takemura	438	162	
	BD	5	6	3	6	6	9	8	6/17/97	Yamazaki et al.	437	228	

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AB	5 8 5 8 8 2 3	1/12/99	Yamazaki, et al.	438	166	
AC	5 8 8 6 3 6 6	3/23/99	Yamazaki, et al.	257	59	
AD	5 8 9 3 7 3 0	4/13/99	Yamazaki, et al.	438	166	
AE						
AF						
AG						
AH						
AI						
AJ						
AK						

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
AL	JP 6-232059	8/19/94	Japan			X	
AM	JP 06-244103	9/2/94	Japan			Abstract only	X
AN							
AO							
AP							

OTHER DOCUMENTS (including Author, Title, Date, Place of Publication)

AQ	Shimokawa, et al., "Characterization of High-Efficiency Cast-Si Solar Cell Wafers by MBIC Measurement", Japanese Journal of Applied Physics Vol. 27, No. 5, pp.751-758, May 1988.
AP	
AS	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Disclosure Form (PTO-1449)